Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10588437	YAMAGUCHI ET AL.	
Examiner	Art Unit	
STEVEN M CERNOCH	4114	

SEARCHED					
Class	Subclass	Date	Examiner		
239	690, 706	12/17/2007	SMC		
239	708, 690.1, 302, 328, 332	1/2/2008	SMC		
239	308, 316	1/3/2008	SMC		

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST	12/14/2007	SMC		
EAST	12/17/2007	SMC		
EAST	1/2/2008	SMC		
EAST	1/3/2008	SMC		
Discussed allowable subject matter with Primary Dinh Nguyen - Casing feature	1/3/2008	SMC		

INTERFERENCE SEARCH					
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